

**Search Notes**

Application/Control No.

10/757,156

Examiner

J. Derek Rutten

Applicant(s)/Patent under  
Reexamination

DEWITT ET AL.

Art Unit

2192

**SEARCHED**

Class	Subclass	Date	Examiner
717	130,158, 159	6/19/2007	JDR
712	240	6/19/2007	JDR
714	45	6/19/2007	JDR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
See Search Notes		6/19/2007	JDR

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history printout	6/14/2007	JDR
717/130-133,151-153,155,156,158- 160; 712/233-244; 714/35,46 Text search only See search history printout	6/14/2007	JDR
ACM - portal.acm.org IEEE - ieeexplore.ieee.org See search history printout	6/14/2007	JDR
Tuan Dam, SPE 2192 (consulted re. allowable subject matter)	6/14/2007	JDR
717/130,158,159; 712/240; 714/45 text search only See search history printout	6/19/2007	JDR